

General Description:

The LWN2007AD2 uses trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications. The package form is DFN2*2-6L, which accords with the ROHS standard and Halogen Free standard.

Features:

- Fast Switching
- Low Gate Charge and $R_{DS(ON)}$
- Low Reverse transfer capacitances

Applications:

- DC-DC Converter
- Portable Equipment
- Power Management

100% DVDS Tested

100% Avalanche Tested



Package Marking and Ordering Information:

Marking	Part Number	Package	Packing	Qty.
N2007A/D.C.	LWN2007AD2	DFN2*2-6L	Reel	3000 Pcs

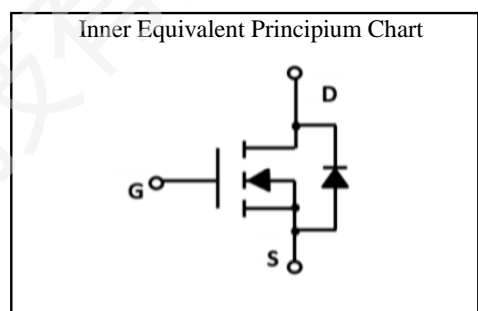
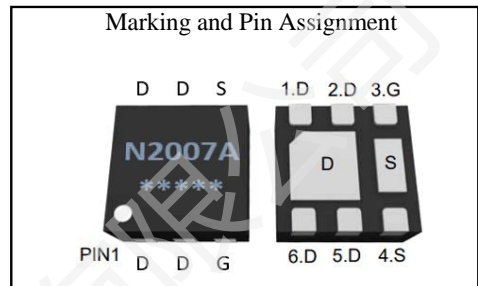
Absolute Maximum Ratings:

Symbol	Parameter	Value	Units
V_{DSS}	Drain-to-Source Voltage	20	V
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$	15
	Continuous Drain Current	$T_A=100^\circ\text{C}$	9.5
I_{DM}^{a1}	Pulsed Drain Current	60	A
E_{AS}^{a2}	Single pulse avalanche energy	110	mJ
V_{GS}	Gate-to-Source Voltage	± 10	V
P_D	Power Dissipation	2.2	W
T_J, T_{STG}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	260	$^\circ\text{C}$

Thermal Characteristics:

Symbol	Parameter	Value	Units
$R_{\theta JA}^{a3}$	Thermal Resistance, Junction-to-Ambient	57	$^\circ\text{C}/\text{W}$

V_{DSS}	20	V
I_D	15	A
P_D	2.2	W
$R_{DS(ON) \text{ TYPE}}$	4.0	$\text{m}\Omega$



Electrical Characteristic ($T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified):

Static Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	20	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=20V, V_{GS}=0V$	--	--	1.0	μA
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+10V, V_{DS}=0V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-10V, V_{DS}=0V$	--	--	-100	nA
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	0.45	0.68	1.0	V
$R_{DS(ON)1}$	Drain-to-Source On-Resistance	$V_{GS}=4.5V, I_D=15A$	--	4.0	6.0	$m\Omega$
$R_{DS(ON)2}$	Drain-to-Source On-Resistance	$V_{GS}=2.5V, I_D=12A$	--	5.2	7.5	$m\Omega$

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS}=0V$	--	1827	--	pF
C_{oss}	Output Capacitance	$V_{DS}=10V$	--	297	--	
C_{riss}	Reverse Transfer Capacitance	$f=1.0MHz$	--	273	--	
R_G	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	--	1.4	--	Ω

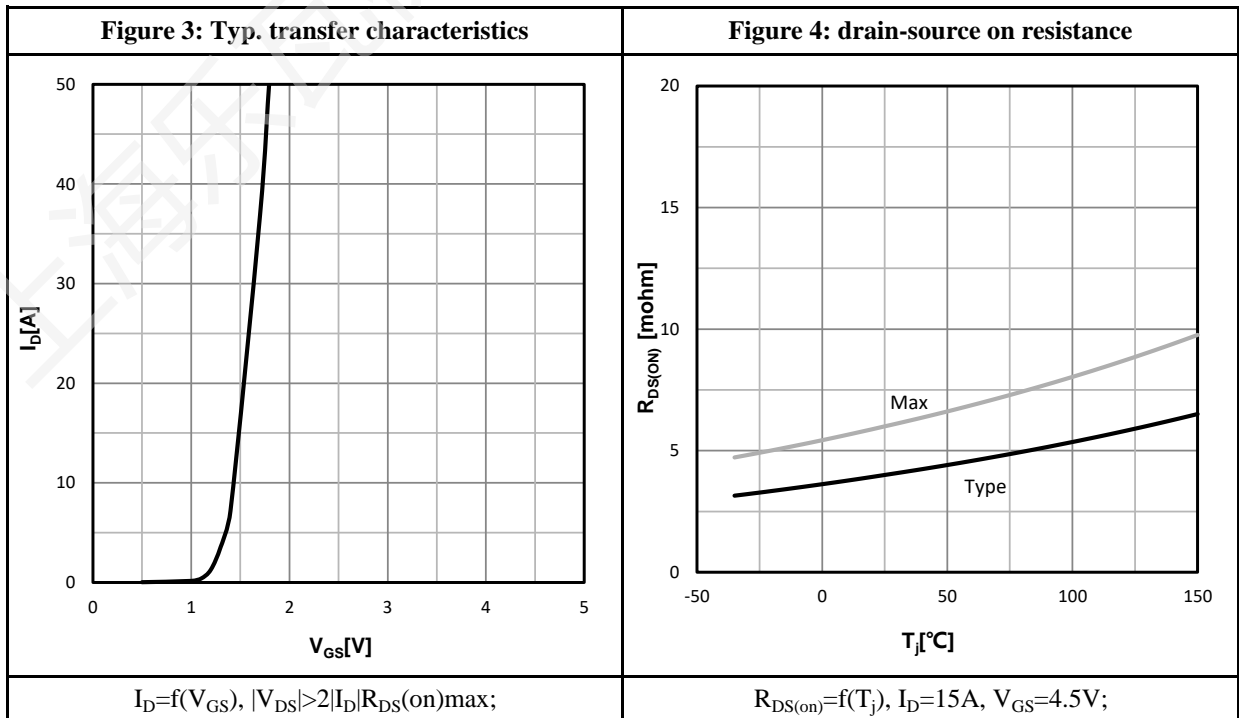
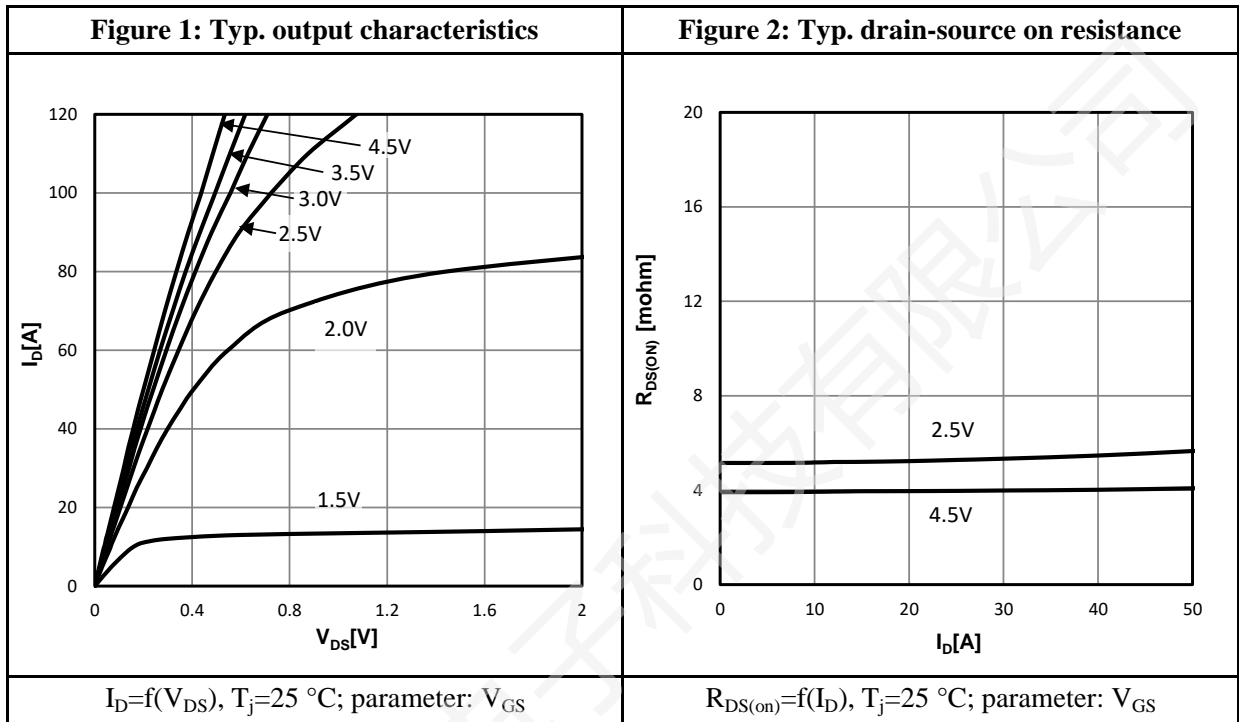
Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=10A$	--	30	--	ns
t_r	Rise Time	$V_{DS}=10V$	--	12	--	
$t_{d(OFF)}$	Turn-Off Delay Time	$V_{GS}=4.5V$	--	35	--	
t_f	Fall Time	$R_G=3.0\Omega$	--	21	--	
Q_g	Total Gate Charge	$V_{GS}=4.5V$	--	27	--	nC
Q_{gs}	Gate to Source Charge	$V_{DS}=10V$	--	2.6	--	
Q_{gd}	Gate to Drain Charge	$I_D=10A$	--	9.8	--	

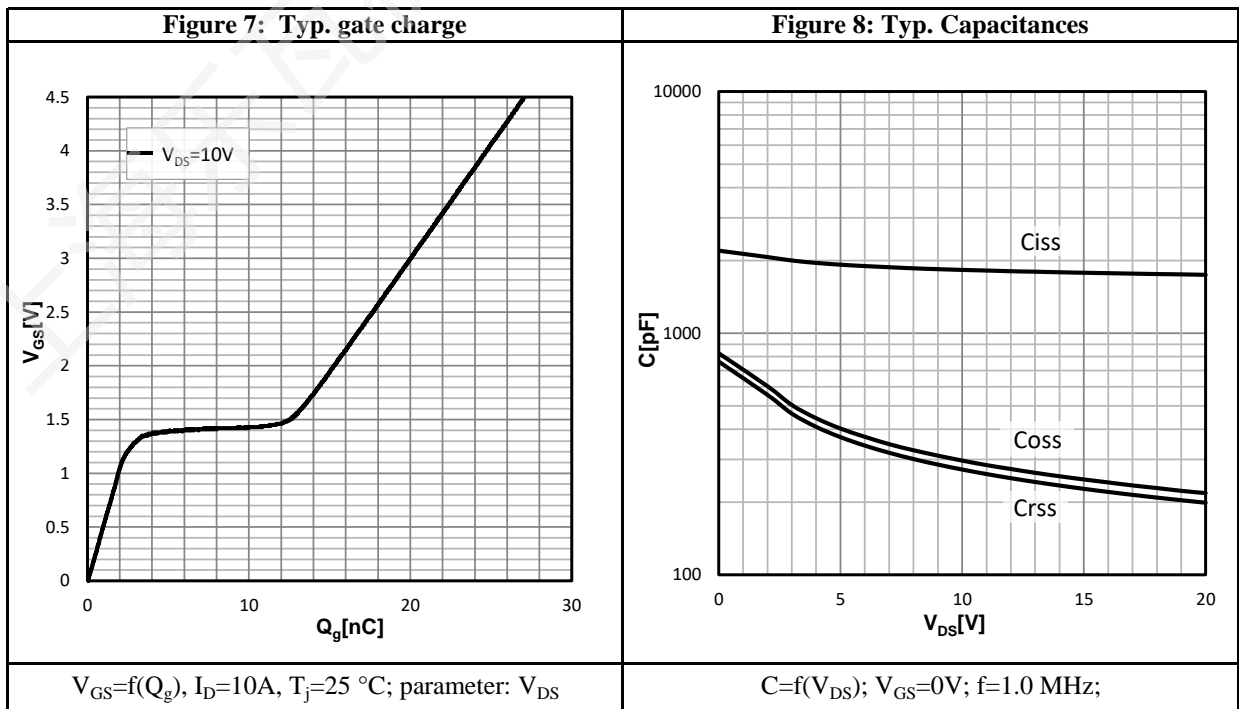
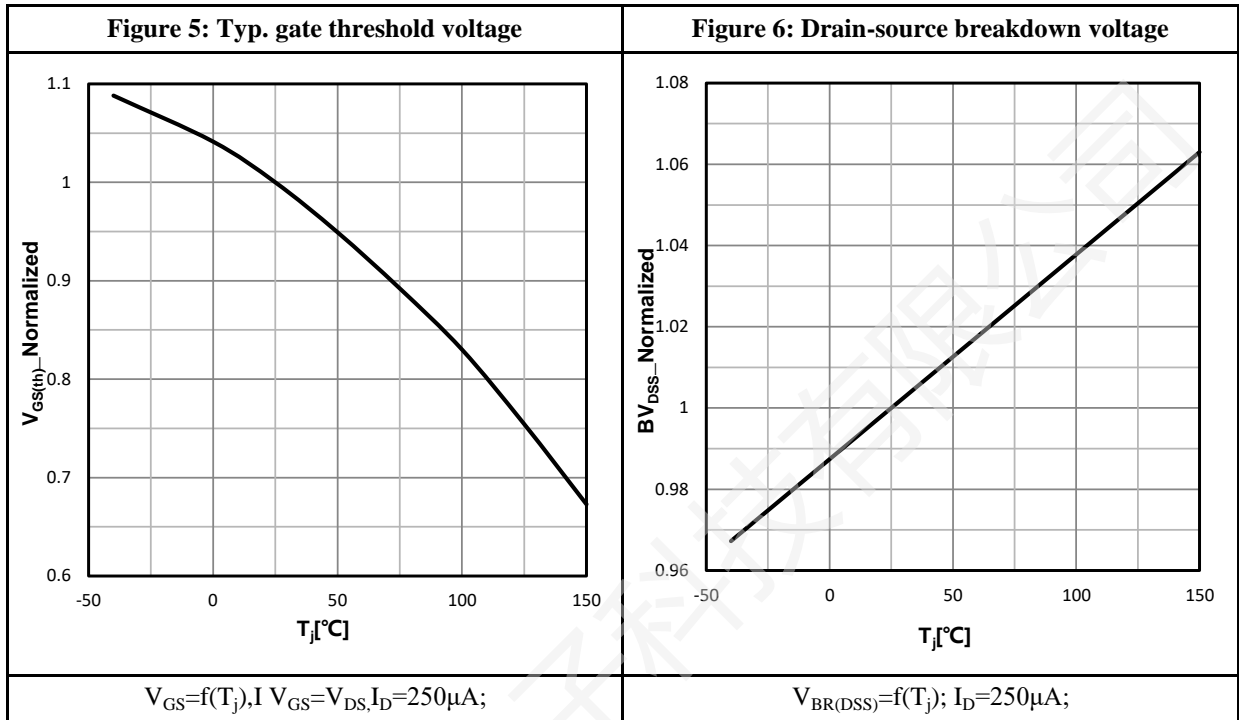
Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Value			Units
			Min.	Typ.	Max.	
I_S	Diode Forward Current	$T_A=25\text{ }^\circ\text{C}$	--	--	15	A
V_{SD}	Diode Forward Voltage	$I_S=15A, V_{GS}=0V$	--	--	1.2	V

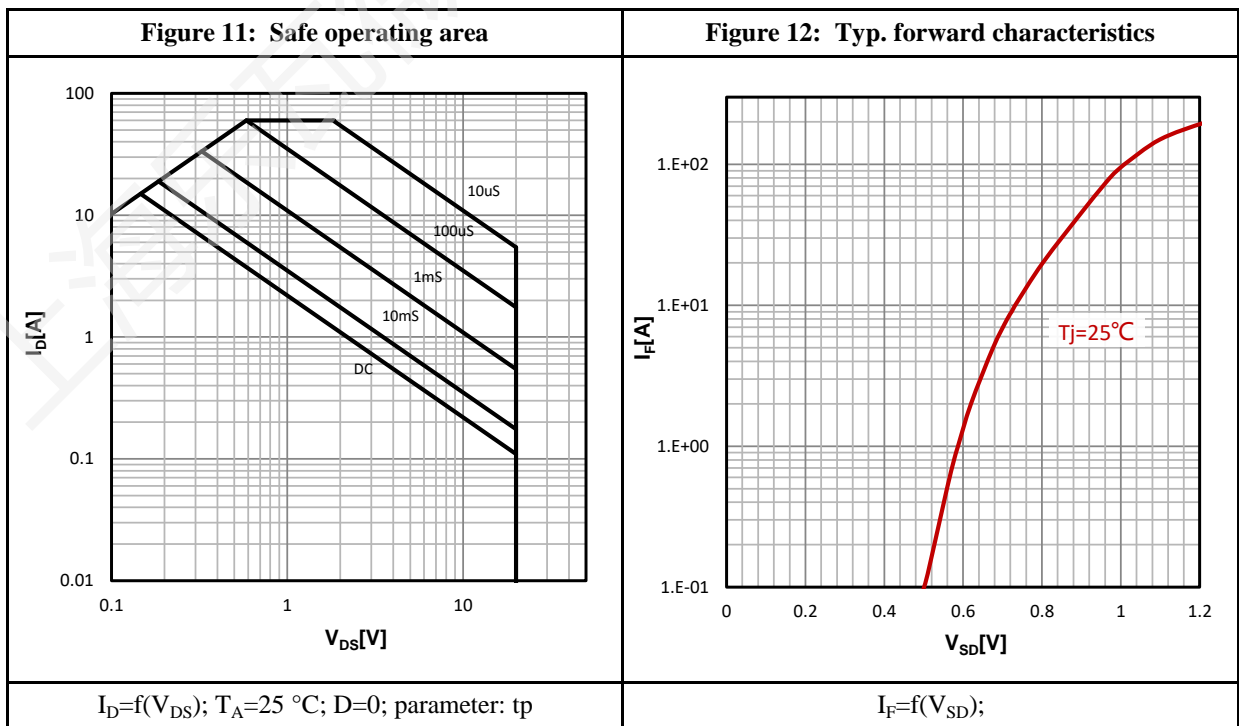
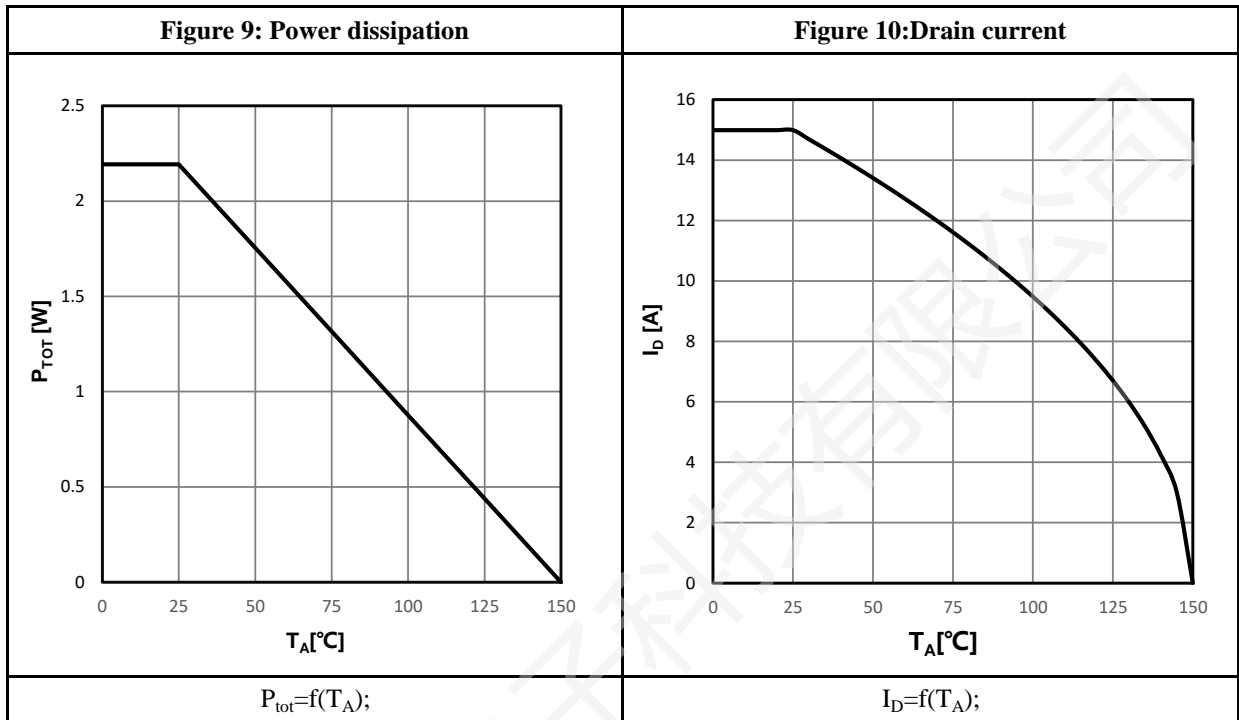
a1: Repetitive rating; pulse width limited by maximum junction temperature

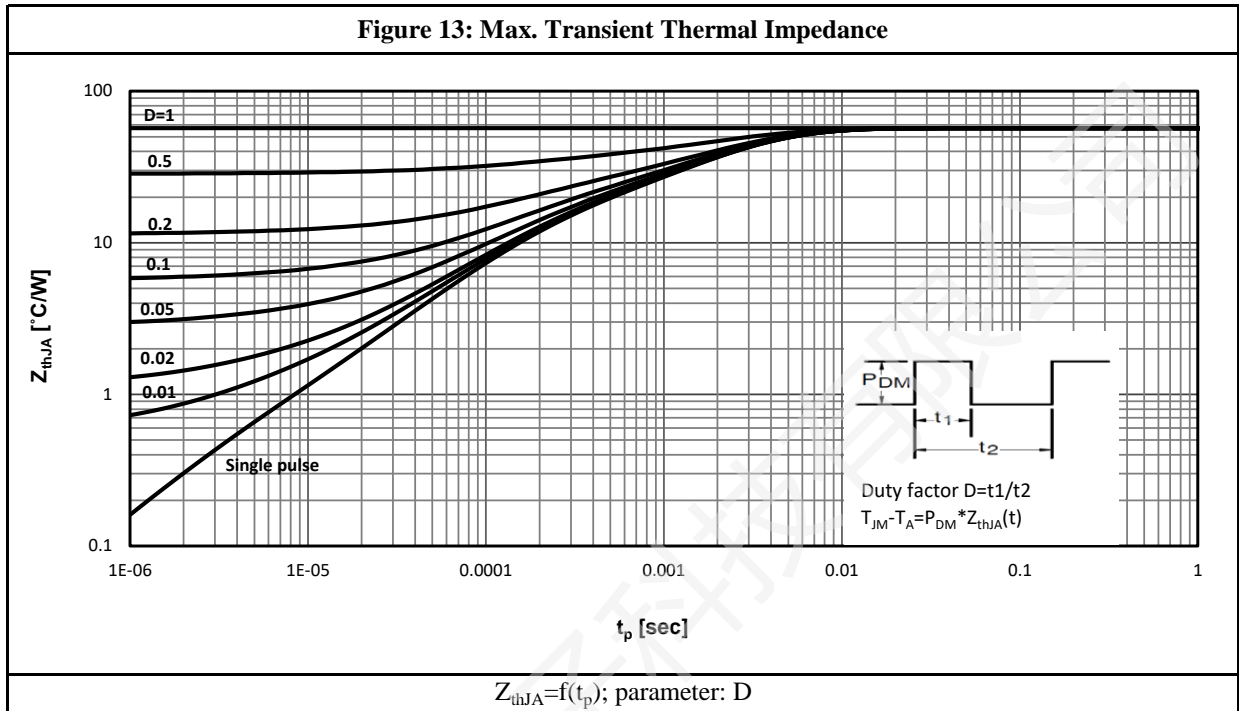
a2: $V_{DD}=15V, L=0.1mH, R_G=25\Omega$, Starting $T_j=25\text{ }^\circ\text{C}$

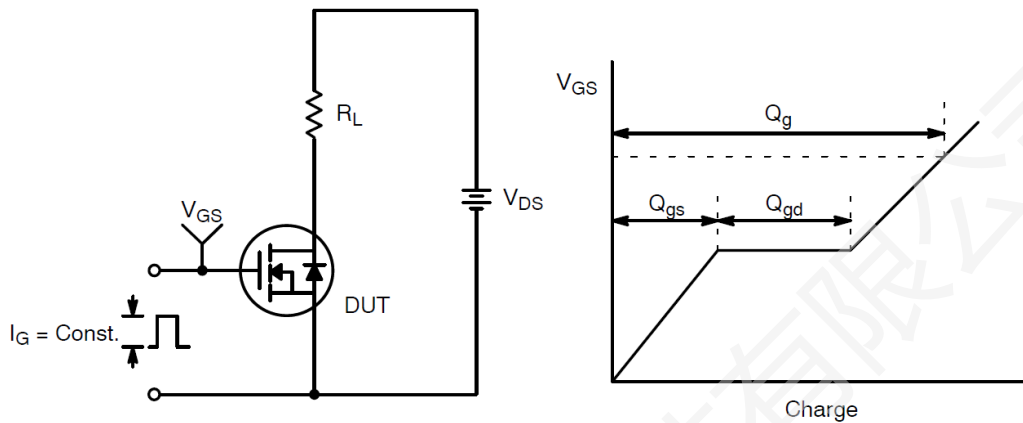
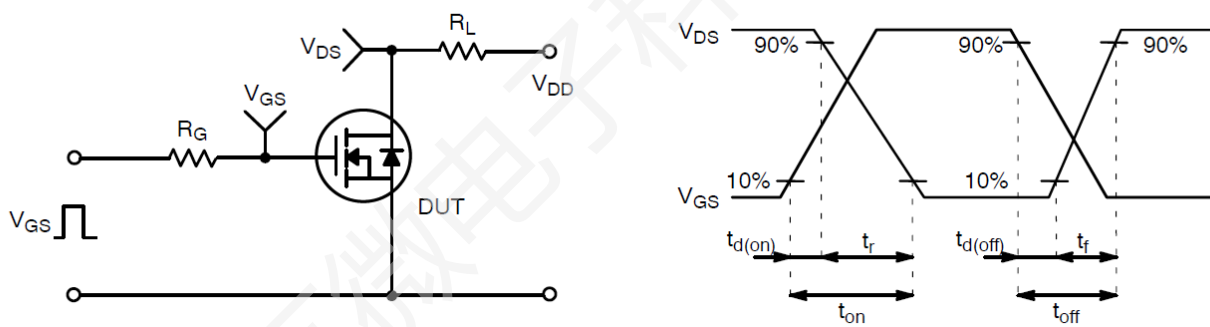
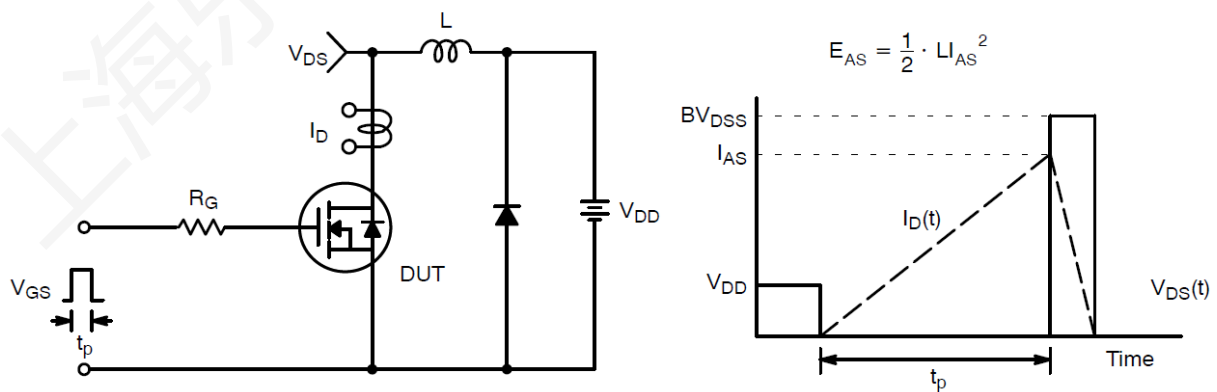
a3: Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection.

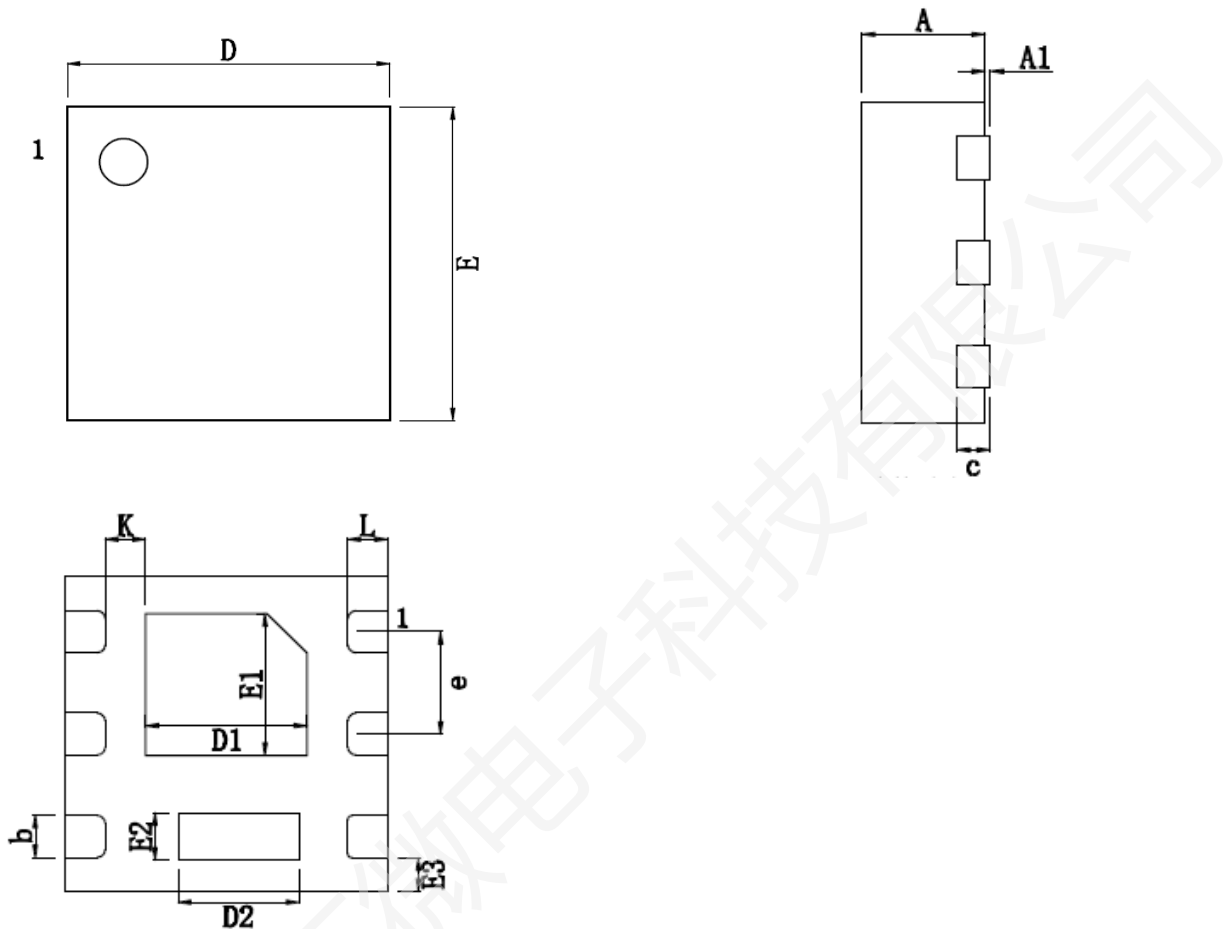
Characteristics Curve:








Test Circuit & Waveform:

Figure 14: Gate Charge Test Circuit & Waveform

Figure 15: Resistive Switching Test Circuit & Waveforms

Figure 16: Unclamped Inductive Switching Test Circuit & Waveforms

Package Outline:


SYMBOL	MILIMETER		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	—	0.05
b	0.22	0.29	0.35
c	0.203 TYP		
D	1.95	2.00	2.05
D1	0.90	1.00	1.10
D2	0.55	0.70	0.85
E	1.95	2.00	2.05
E1	0.80	0.90	1.00
E2	0.25	0.30	0.35
E3	0.215 REF		
e	0.65 BSC		
K	0.25 REF		
L	0.20	0.25	0.30

Revision History:

Revison	Date	Descriptions
Rev 1.1	July.2025	Initial Version

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